

## DUAL MODE COATING THICKNESS MEASURING INSTRUMENT

### ABSTRACT OF THE DISCLOSURE

A coating thickness measuring instrument is provided. The coating thickness measuring instrument has a first mode of operation in which it is operative to make measurements with a first resolution and a second mode of operation in which it is operative to make measurements with a second resolution, the first resolution being greater than the second. The instrument may provide a first short range high resolution mode and a second long range low resolution mode. The first range may be contained in or overlap the second range.

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